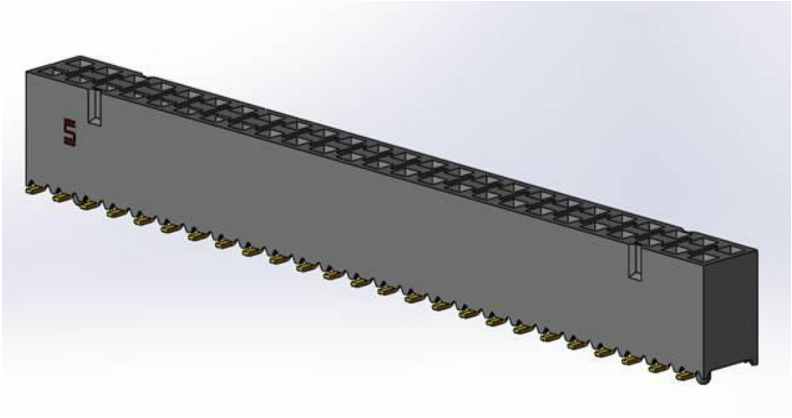
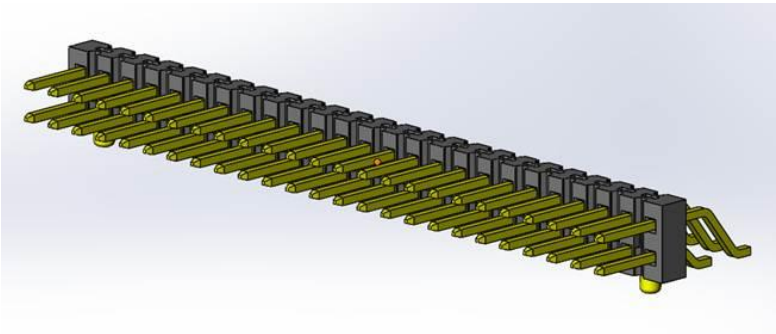
Project Number: Design Qualification Test Report	Tracking Code: 302828_Report_Rev_1
Requested by: Catie Eichhorn	Date: 12/18/2014
Part #: SSM-125-L-DV-A/TSM-125-01-L-DH-A	Tech: Peter Chen
Part description: SSM/TSM	Qty to test: 100
Test Start: 03/20/2014	Test Completed: 05/13/2014





DESIGN QUALIFICATION TEST REPORT

SSM/TSM
SSM-125-L-DV-A/TSM-125-01-L-DH-A

REVISION HISTORY

DATA	REV.NUM.	DESCRIPTION	ENG
12/16/2014	**1**	**Initial Issue**	**PC**

CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to IS0 10012-l and ANSI/NCSL 2540-1, as applicable.

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SCOPE

To perform the following tests: Design Qualification test. Please see test plan.

APPLICABLE DOCUMENTS

Standards: EIA Publication 364

TEST SAMPLES AND PREPARATION

1) All materials were manufactured in accordance with the applicable product specification.
2) All test samples were identified and encoded to maintain traceability throughout the test sequences.
3) After soldering, the parts to be used for LLCR and DWV/IR testing were cleaned according to TLWI-0001.
4) Either an automated cleaning procedure or an ultrasonic cleaning procedure may be used.
5) The automated procedure is used with aqueous compatible soldering materials.
6) Parts not intended for testing LLCR and DWV/IR are visually inspected and cleaned if necessary.
7) Any additional preparation will be noted in the individual test sequences.
8) Solder Information: Lead free
9) Samtec Test PCBs used: PCB-106170-TST, PCB-106172-TST.

FLOWCHARTS

Gas Tight

Group 1
SSM-125-L-DV-A
TSM-125-01-L-DH-A
8 Assemblies

Step	Description
1.	LLCR (2) Max Delta = 15 mOhm
2.	Gas Tight (1)
3.	LLCR (2) Max Delta = 15 mOhm

(1) Gas Tight = EIA-364-36

(2) LLCR = EIA-364-23
Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max

Normal Force

Group 1
SSM-125-L-DV-A
TSM-125-01-L-DH-A
8 Contacts Minimum
Signal Without Thermals

Step	Description
1.	Contact Gaps
2.	Normal Force (1) Deflection = 0.005 " Expected Force at Max Deflection = 130 g

Group 2
SSM-125-L-DV-A
TSM-125-01-L-DH-A
8 Contacts Minimum
Signal With Thermals

Step	Description
1.	Contact Gaps
2.	Thermal Age (2)
3.	Contact Gaps
4.	Normal Force (1) Deflection = 0.005 " Expected Force at Max Deflection = 130 g

(1) Normal Force = EIA-364-04

(2) Thermal Age = EIA-364-17
Test Condition = 4 (105°C)
Time Condition = B (250 Hours)

FLOWCHARTS Continued

Thermal Aging

Group 1
SSM-125-L-DV-A
TSM-125-01-L-DH-A
8 Assemblies

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force (2)
3.	LLCR (1) Max Delta = 15 mOhm
4.	Thermal Age (3)
5.	LLCR (1) Max Delta = 15 mOhm
6.	Mating/Unmating Force (2)
7.	Contact Gaps

(1) LLCR = EIA-364-23
Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max

(2) Mating/Unmating Force = EIA-364-13

(3) Thermal Age = EIA-364-17
Test Condition = 4 (105°C)
Time Condition = B (250 Hours)

FLOWCHARTS Continued

Mating/Unmating/Durability

Group 1 SSM-125-L-DV-A TSM-125-01-L-DH-A 8 Assemblies		Group 2 SSM-140-L-DV TSM-140-01-L-DH-A 8 Assemblies		Group 3 SSM-110-L-DV-A TSM-110-01-L-DH-A 8 Assemblies	
Step	**Description**	**Step**	**Description**	**Step**	**Description**
1.	Contact Gaps	1.	Contact Gaps	1.	Contact Gaps
2.	LLCR (2) Max Delta = 15 mOhm	2.	Mating/Unmating Force (3)	2.	Mating/Unmating Force (3)
3.	Mating/Unmating Force (3)	3.	Cycles Quantity = 25 Cycles	3.	Cycles Quantity = 25 Cycles
4.	Cycles Quantity = 25 Cycles	4.	Mating/Unmating Force (3)	4.	Mating/Unmating Force (3)
5.	Mating/Unmating Force (3)	5.	Cycles Quantity = 25 Cycles	5.	Cycles Quantity = 25 Cycles
6.	Cycles Quantity = 25 Cycles	6.	Mating/Unmating Force (3)	6.	Mating/Unmating Force (3)
7.	Mating/Unmating Force (3)	7.	Cycles Quantity = 25 Cycles	7.	Cycles Quantity = 25 Cycles
8.	Cycles Quantity = 25 Cycles	8.	Mating/Unmating Force (3)	8.	Mating/Unmating Force (3)
9.	Mating/Unmating Force (3)	9.	Cycles Quantity = 25 Cycles	9.	Cycles Quantity = 25 Cycles
10.	Cycles Quantity = 25 Cycles	10.	Mating/Unmating Force (3)	10.	Mating/Unmating Force (3)
11.	Mating/Unmating Force (3)				
12.	Contact Gaps				
13.	LLCR (2) Max Delta = 15 mOhm				
14.	Thermal Shock (4)				
15.	LLCR (2) Max Delta = 15 mOhm				
16.	Humidity (1)				
17.	LLCR (2) Max Delta = 15 mOhm				
18.	Mating/Unmating Force (3)				

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(1) Humidity = EIA-364-31
Test Condition = B (240 Hours)
Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)
Test Exceptions: ambient pre-condition and delete steps 7a ar

(2) LLCR = EIA-364-23
Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max

(3) Mating/Unmating Force = EIA-364-13

(4) Thermal Shock = EIA-364-32
Exposure Time at Temperature Extremes = 1/2 Hour
Method A, Test Condition = I (-55°C to +85°C)
Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued

IR/DWV

Pin-to-Pin

Group 1 SSM-125-L-DV-A TSM-125-01-L-DH-A 2 Assemblies		Group 2 SSM-125-L-DV-A 2 Assemblies		Group 3 TSM-125-01-L-DH-A 2 Assemblies		Group 4 SSM-125-L-DV-A TSM-125-01-L-DH-A 2 Assemblies	
Step	**Description**	**Step**	**Description**	**Step**	**Description**	**Step**	**Description**
1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

Row-to-Row

Group 5 SSM-125-L-DV-A TSM-125-01-L-DH-A 2 Assemblies		Group 6 SSM-125-L-DV-A 2 Assemblies		Group 7 TSM-125-01-L-DH-A 2 Assemblies		Group 8 SSM-125-L-DV-A TSM-125-01-L-DH-A 2 Assemblies	
Step	**Description**	**Step**	**Description**	**Step**	**Description**	**Step**	**Description**
1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

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(1) DWV at Test Voltage = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds

(2) DWV Breakdown = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds

(3) Humidity = EIA-364-31
Test Condition = B (240 Hours)
Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)
Test Exceptions: ambient pre-condition and delete steps 7a and 7b

(4) IR = EIA-364-21
Test Condition = 500 Vdc, 2 Minutes Max

(5) Thermal Shock = EIA-364-32
Exposure Time at Temperature Extremes = 1/2 Hour
Method A, Test Condition = I (-55°C to +85°C)
Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued

Current Carrying Capacity

Group 1
SSM-140-L-DV
TSM-140-01-L-DH-A
2 Pins Powered
Signal

Step	Description
1.	CCC (1) Rows = 2 Number of Positions = 1

Group 2
SSM-140-L-DV
TSM-140-01-L-DH-A
4 Pins Powered
Signal

Step	Description
1.	CCC (1) Rows = 2 Number of Positions = 2

Group 3
SSM-140-L-DV
TSM-140-01-L-DH-A
6 Pins Powered
Signal

Step	Description
1.	CCC (1) Rows = 2 Number of Positions = 3

Group 4
SSM-140-L-DV
TSM-140-01-L-DH-A
8 Pins Powered
Signal

Step	Description
1.	CCC (1) Rows = 2 Number of Positions = 4

Group 5
SSM-140-L-DV
TSM-140-01-L-DH-A
80 Pins Powered
Signal

Step	Description
1.	CCC (1) Rows = 2 Number of Positions = 40

(1) CCC = EIA-364-70
Method 2, Temperature Rise Versus Current Curve
(TIN PLATING) - Tabulate calculated current at RT, 65°C, 75°C and 95°C after derating 20% and based on 105°C
(GOLD PLATING) - Tabulate calculated current at RT, 85°C, 95°C and 115°C after derating 20% and based on 125°C

FLOWCHARTS Continued

Mechanical Shock/Random Vibration/LLCR

Group 1
SSM-125-L-DV-A
TSM-125-01-L-DH-A
8 Assemblies

Step	Description
1.	LLCR (1) Max Delta = 15 mOhm
2.	Mechanical Shock (2)
3.	Random Vibration (3)
4.	LLCR (1) Max Delta = 15 mOhm

(1) LLCR = EIA-364-23
Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max

(2) Mechanical Shock = EIA-364-27
Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)
Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(3) Random Vibration = EIA-364-28
Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

Mechanical Shock/Random Vibration/Event Detection

Group 1
SSM-125-L-DV-A
TSM-125-01-L-DH-A
60 Points

Step	Description
1.	Nanosecond Event Detection (Mechanical Shock) (1)
2.	Nanosecond Event Detection (Random Vibration) (2)

(1) Nanosecond Event Detection (Mechanical Shock)
Use EIA-364-87 for Nanosecond Event Detection:
Test Condition = F (50 nanoseconds at 10 ohms)
Use EIA-364-27 for Mechanical Shock:
Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)
Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(2) Nanosecond Event Detection (Random Vibration)
Use EIA-364-87 for Nanosecond Event Detection:
Test Condition = F (50 nanoseconds at 10 ohms)
Use EIA-364-28 for Random Vibration:
Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

FLOWCHARTS Continued

Extended Life

Group 1 SSM-125-S-DV-A TSM-125-01-S-DH-A 8 Assemblies 250 Cycles		Group 2 SSM-125-S-DV-A TSM-125-01-S-DH-A 8 Assemblies 500 Cycles		Group 3 SSM-125-S-DV-A TSM-125-01-S-DH-A 8 Assemblies 1000 Cycles		Group 4 SSM-125-S-DV-A TSM-125-01-S-DH-A 8 Assemblies 2500 Cycles	
Step	**Description**	**Step**	**Description**	**Step**	**Description**	**Step**	**Description**
1.	Plating Thickness Verification (4)	1.	Plating Thickness Verification (4)	1.	Plating Thickness Verification (4)	1.	Plating Thickness Verification (4)
2.	LLCR (2) Max Delta = 15 mOhm	2.	LLCR (2) Max Delta = 15 mOhm	2.	LLCR (2) Max Delta = 15 mOhm	2.	LLCR (2) Max Delta = 15 mOhm
3.	Cycles Quantity = 250 Cycles	3.	Cycles Quantity = 500 Cycles	3.	Cycles Quantity = 1000 Cycles	3.	Cycles Quantity = 2500 Cycles
4.	LLCR (2) Max Delta = 15 mOhm	4.	LLCR (2) Max Delta = 15 mOhm	4.	LLCR (2) Max Delta = 15 mOhm	4.	LLCR (2) Max Delta = 15 mOhm
5.	Thermal Shock (5)	5.	Thermal Shock (5)	5.	Thermal Shock (5)	5.	Thermal Shock (5)
6.	LLCR (2) Max Delta = 15 mOhm	6.	LLCR (2) Max Delta = 15 mOhm	6.	LLCR (2) Max Delta = 15 mOhm	6.	LLCR (2) Max Delta = 15 mOhm
7.	Humidity (1)	7.	Humidity (1)	7.	Humidity (1)	7.	Humidity (1)
8.	LLCR (2) Max Delta = 15 mOhm	8.	LLCR (2) Max Delta = 15 mOhm	8.	LLCR (2) Max Delta = 15 mOhm	8.	LLCR (2) Max Delta = 15 mOhm
9.	Photos (3)	9.	Photos (3)	9.	Photos (3)	9.	Photos (3)

(1) Humidity = EIA-364-31
Test Condition = B (240 Hours)
Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)
Test Exceptions: ambient pre-condition and delete steps 7a and 7b

(2) LLCR = EIA-364-23
Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max

(3) Photos
Attach 2-3 photos of contact area

(4) Plating Thickness Verification
Measure, verify, and document plating thickness on both male and female (one group only)
Plating thickness to be measured on loose pins used during assembly

(5) Thermal Shock = EIA-364-32
Exposure Time at Temperature Extremes = 1/2 Hour
Method A, Test Condition = I (-55°C to +85°C)
Test Duration = A-3 (100 Cycles)

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

THERMAL SHOCK:

1) EIA-364-32, *Thermal Shock (Temperature Cycling) Test Procedure for Electrical Connectors.*
2) Test Condition 1: -55°C to +85°C
3) Test Time: ½ hour dwell at each temperature extreme
4) Number of Cycles: 100
5) All test samples are pre-conditioned at ambient.
6) All test samples are exposed to environmental stressing in the mated condition.

THERMAL:

1) EIA-364-17, *Temperature Life with or without Electrical Load Test Procedure for Electrical Connectors.*
2) Test Condition 4 at 105° C
3) Test Time Condition B for 250 hours.
4) All test samples are pre-conditioned at ambient.
5) All test samples are exposed to environmental stressing in the mated condition.

HUMIDITY:

1) Reference document: EIA-364-31, *Humidity Test Procedure for Electrical Connectors.*
2) Test Condition B, 240 Hours.
3) Method III, +25° C to + 65° C, 90% to 98% Relative Humidity excluding sub-cycles 7a and 7b.
4) All samples are pre-conditioned at ambient.
5) All test samples are exposed to environmental stressing in the mated condition.

MECHANICAL SHOCK (Specified Pulse):

1) Reference document: EIA-364-27, *Mechanical Shock Test Procedure for Electrical Connectors*
2) Test Condition C
3) Peak Value: 100 G
4) Duration: 6 Milliseconds
5) Wave Form: Half Sine
6) Velocity: 12.3 ft/s
7) Number of Shocks: 3 Shocks / Direction, 3 Axis (18 Total)

VIBRATION:

1) Reference document: EIA-364-28, *Vibration Test Procedure for Electrical Connectors*
2) Test Condition V, Letter B
3) Power Spectral Density: 0.04 G^2 / Hz
4) G 'RMS': 7.56
5) Frequency: 50 to 2000 Hz
6) Duration: 2.0 Hours per axis (3 axis total)

NANOSECOND-EVENT DETECTION:

1) Reference document: EIA-364-87, *Nanosecond-Event Detection for Electrical Connectors*
2) Prior to test, the samples were characterized to assure the low nanosecond event being monitored will trigger the detector.
3) After characterization it was determined the test samples could be monitored for 50 nanosecond events

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

TEMPERATURE RISE (Current Carrying Capacity, CCC):

1) EIA-364-70, *Temperature Rise versus Current Test Procedure for Electrical Connectors and Sockets*.
2) When current passes through a contact, the temperature of the contact increases as a result of I^2R (resistive) heating.
3) The number of contacts being investigated plays a significant part in power dissipation and therefore temperature rise.
4) The size of the temperature probe can affect the measured temperature.
5) Copper traces on PC boards will contribute to temperature rise:
    a. Self heating (resistive)
    b. Reduction in heat sink capacity affecting the heated contacts
6) A de-rating curve, usually 20%, is calculated.
7) Calculated de-rated currents at four temperature points are reported:
    a. Ambient
    b. 85^{o} C
    c. 95^{o} C
    d. 115^{o} C
8) Typically, neighboring contacts (in close proximity to maximize heat build up) are energized.
9) The thermocouple (or temperature measuring probe) will be positioned at a location to sense the maximum temperature in the vicinity of the heat generation area.
10) A computer program, *TR 803.exe*, ensures accurate stability for data acquisition.
11) Hook-up wire cross section is larger than the cross section of any connector leads/PC board traces, jumpers, etc.
12) Hook-up wire length is longer than the minimum specified in the referencing standard.

LLCR:

1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
    a. <= +5.0 mOhms:---------- Stable
    b. +5.1 to +10.0 mOhms:---------- Minor
    c. +10.1 to +15.0 mOhms: ---------- Acceptable
    d. +15.1 to +50.0 mOhms: ---------- Marginal
    e. +50.1 to +2000 mOhms: ---------- Unstable
    f. >+2000 mOhms:---------- Open Failure

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

GAS TIGHT:

To provide method for evaluating the ability of the contacting surfaces in preventing penetration of harsh vapors which might lead to oxide formation that may degrade the electrical performance of the contact system.

1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
    a. <= +5.0 mOhms:---------- Stable
    b. +5.1 to +10.0 mOhms:---------- Minor
    c. +10.1 to +15.0 mOhms: ---------- Acceptable
    d. +15.1 to +50.0 mOhms: ---------- Marginal
    e. +50.1 to +2000 mOhms: ---------- Unstable
    f. >+2000 mOhms:---------- Open Failure
4) Procedure:
    a. Reference document: EIA-364-36, *Test Procedure for Determination of Gas-Tight Characteristics for Electrical Connectors, Sockets and/or Contact Systems*.
    b. Test Conditions:
        i. Class II--- Mated pairs of contacts assembled to their plastic housings.
        ii. Reagent grade Nitric Acid shall be used of sufficient volume to saturate the test chamber
        iii. The ratio of the volume of the test chamber to the surface area of the acid shall be 10:1.
        iv. The chamber shall be saturated with the vapor for at least 15 minutes before samples are added.
        v. Exposure time, 55 to 65 minutes.
        vi. The samples shall be no closer to the chamber walls than 1 inches and no closer to the surface of the acid than 3 inches.
        vii. The samples shall be dried after exposure for a minimum of 1 hour.
        viii. Drying temperature 50^{o} C
        ix. The final LLCR shall be conducted within 1 hour after drying.

NORMAL FORCE (FOR CONTACTS TESTED OUTSIDE THE HOUSING):

1) Reference document: EIA-364-04, *Normal Force Test Procedure for Electrical Connectors*.
2) The contacts shall be tested in the loose state, *not* inserted in connector housing.
3) The contacts shall be prepared to allow access to the spring member at the same attitude and deflection level as would occur in actual use.
4) In the event that portions of the contact prevent insertion of the test probe and/or deflection of the spring member under evaluation, said material shall be removed leaving the appropriate contact surfaces exposed.
5) In the case of multi-tine contacts, each tine shall be tested independently on separate samples as required.
6) The connector housing shall be simulated, if required, in order to provide an accurate representation of the actual contact system performance.
7) A holding fixture shall be fashioned to allow the contact to be properly deflected.
8) Said holding fixture shall be mounted on a floating, adjustable, X-Y table on the base of the Dillon TC^2, computer controlled test stand with a deflection measurement system accuracy of 5 μm (0.0002").
9) The probe shall be attached to a Dillon P/N 49761-0105, 5 N (1.1 Lb) load cell providing an accuracy of ± 0.2%.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes

10) The nominal deflection rate shall be 5 mm (0.2")/minute.
11) Unless otherwise noted a minimum of five contacts shall be tested.
12) The force/deflection characteristic to load and unload each contact shall be repeated five times.
13) The system shall utilize the TC^2 software in order to acquire and record the test data.
14) The permanent set of each contact shall be measured within the TC^2 software.
15) The acquired data shall be graphed with the deflection data on the X-axis and the force data on the Y-axis and a print out will be stored with the Tracking Code paperwork.

INSULATION RESISTANCE (IR):

To determine the resistance of insulation materials to leakage of current through or on the surface of these materials when a DC potential is applied.

1) PROCEDURE:
    a. Reference document: EIA-364-21, *Insulation Resistance Test Procedure for Electrical Connectors*.
    b. Test Conditions:
        i. Between Adjacent Contacts or Signal-to-Ground
        ii. Electrification Time 2.0 minutes
        iii. Test Voltage (500 VDC) corresponds to calibration settings for measuring resistances.
2) MEASUREMENTS:
3) When the specified test voltage is applied (VDC), the insulation resistance shall not be less than 5000 megohms.

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

To determine if the sockets can operate at its rated voltage and withstand momentary over potentials due to switching, surges, and other similar phenomenon. Separate samples are used to evaluate the effect of environmental stresses so not to influence the readings from arcing that occurs during the measurement process.

1) PROCEDURE:
    a. Reference document: EIA-364-20, *Withstanding Voltage Test Procedure for Electrical Connectors*.
    b. Test Conditions:
        i. Between Adjacent Contacts or Signal-to-Ground
        ii. Barometric Test Condition 1
        iii. Rate of Application 500 V/Sec
        iv. Test Voltage (VAC) until breakdown occurs
2) MEASUREMENTS/CALCULATIONS
    a. The breakdown voltage shall be measured and recorded.
    b. The dielectric withstanding voltage shall be recorded as 75% of the minimum breakdown voltage.
    c. The working voltage shall be recorded as one-third (1/3) of the dielectric withstanding voltage (one-fourth of the breakdown voltage).

RESULTS

Temperature Rise, CCC at a 20% de-rating

- **CCC for a 30°C Temperature Rise----------5.6 A per contact with 2 contacts (2x1) powered**
- **CCC for a 30°C Temperature Rise----------4.1 A per contact with 4 contacts (2x2) powered**
- **CCC for a 30°C Temperature Rise----------3.5 A per contact with 6 contacts (2x3) powered**
- **CCC for a 30°C Temperature Rise----------3.2 A per contact with 8 contacts (2x4) powered**
- **CCC for a 30°C Temperature Rise----------2.0 A per contact with 80 contacts (2x40) powered**

Mating – Unmating Forces

Thermal Aging Group （SSM-125-L-DV-A/TSM-125-01-L-DH-A）

- **Initial**
  - **Mating**
    - **Min ---------- 7.17 Lbs**
    - **Max---------- 7.75 Lbs**
  - **Unmating**
    - **Min ---------- 5.65 Lbs**
    - **Max---------- 6.42 Lbs**
- **After Thermal**
  - **Mating**
    - **Min ---------- 6.33 Lbs**
    - **Max---------- 7.15 Lbs**
  - **Unmating**
    - **Min ---------- 5.45 Lbs**
    - **Max---------- 5.86 Lbs**

RESULTS Continued

Mating – Unmating Forces

Mating-Unmating Durability Gaps Group（SSM-125-L-DV-A/TSM-125-01-L-DH-A）

- **Initial**
  - **Mating**
    - **Min ---------- 6.76 Lbs**
    - **Max---------- 8.23 Lbs**
  - **Unmating**
    - **Min ---------- 5.81 Lbs**
    - **Max---------- 7.15 Lbs**
- **After 25 Cycles**
  - **Mating**
    - **Min ---------- 7.57 Lbs**
    - **Max----------10.02 Lbs**
  - **Unmating**
    - **Min ---------- 6.10 Lbs**
    - **Max---------- 8.13 Lbs**
- **After 50 Cycles**
  - **Mating**
    - **Min ---------- 8.78 Lbs**
    - **Max----------11.68 Lbs**
  - **Unmating**
    - **Min ---------- 7.23 Lbs**
    - **Max---------- 8.76 Lbs**
- **After 75 Cycles**
  - **Mating**
    - **Min ---------- 9.41 Lbs**
    - **Max----------12.23 Lbs**
  - **Unmating**
    - **Min ---------- 8.12 Lbs**
    - **Max---------- 9.22 Lbs**
- **After 100 Cycles**
  - **Mating**
    - **Min ----------10.17 Lbs**
    - **Max----------12.66 Lbs**
  - **Unmating**
    - **Min ---------- 9.13 Lbs**
    - **Max---------- 9.87 Lbs**
- **Humidity**
  - **Mating**
    - **Min ---------- 7.69 Lbs**
    - **Max---------- 9.96 Lbs**
  - **Unmating**
    - **Min ---------- 5.52 Lbs**
    - **Max---------- 7.47 Lbs**

RESULTS Continued

Mating – Unmating Forces

Mating-Unmating Basic （SSM-140-L-DV-A/TSM-140-01-L-DH-A）

- **Initial**
  - **Mating**
    - **Min ----------12.70 Lbs**
    - **Max----------14.03 Lbs**
  - **Unmating**
    - **Min ----------10.23 Lbs**
    - **Max----------11.10 Lbs**
- **After 25 Cycles**
  - **Mating**
    - **Min ----------13.66 Lbs**
    - **Max----------15.75 Lbs**
  - **Unmating**
    - **Min ----------11.66 Lbs**
    - **Max----------12.72 Lbs**
- **After 50 Cycles**
  - **Mating**
    - **Min ----------14.13 Lbs**
    - **Max----------17.13 Lbs**
  - **Unmating**
    - **Min ----------12.66 Lbs**
    - **Max----------13.50 Lbs**
- **After 75 Cycles**
  - **Mating**
    - **Min ----------16.23 Lbs**
    - **Max----------18.44 Lbs**
  - **Unmating**
    - **Min ----------13.13 Lbs**
    - **Max----------16.23 Lbs**
- **After 100 Cycles**
  - **Mating**
    - **Min ----------16.98 Lbs**
    - **Max----------18.76 Lbs**
  - **Unmating**
    - **Min ----------13.80 Lbs**
    - **Max----------17.35 Lbs**

RESULTS Continued

Mating – Unmating Forces

Mating-Unmating Basic （SSM-110-L-DV-A/TSM-110-01-L-DH-A）

- **Initial**
  - **Mating**
    - **Min ---------- 3.75 Lbs**
    - **Max---------- 4.57 Lbs**
  - **Unmating**
    - **Min ---------- 3.02 Lbs**
    - **Max---------- 3.32 Lbs**
- **After 25 Cycles**
  - **Mating**
    - **Min ---------- 4.00 Lbs**
    - **Max---------- 4.84 Lbs**
  - **Unmating**
    - **Min ---------- 3.10 Lbs**
    - **Max---------- 3.67 Lbs**
- **After 50 Cycles**
  - **Mating**
    - **Min ---------- 4.12 Lbs**
    - **Max---------- 5.16 Lbs**
  - **Unmating**
    - **Min ---------- 3.23 Lbs**
    - **Max---------- 4.10 Lbs**
- **After 75 Cycles**
  - **Mating**
    - **Min ---------- 4.23 Lbs**
    - **Max---------- 5.30 Lbs**
  - **Unmating**
    - **Min ---------- 3.41 Lbs**
    - **Max---------- 4.21 Lbs**
- **After 100 Cycles**
  - **Mating**
    - **Min ---------- 4.55 Lbs**
    - **Max---------- 5.45 Lbs**
  - **Unmating**
    - **Min ---------- 3.62 Lbs**
    - **Max---------- 4.25 Lbs**

Normal Force at 0.0061 inch deflection

- **Initial**
  - **Min---------- 243.50 gf Set ----- 0.0000 in**
  - **Max ---------- 289.70 gf Set ----- 0.0008 in**
- **Thermal**
  - **Min---------- 187.20 gf Set----- 0.0003 in**
  - **Max ---------- 254.30 gf Set----- 0.0010 in**

RESULTS Continued

Insulation Resistance minimums, IR

Pin to Pin

- **Initial**
  - **Mated ---------- 10000 Meg Ω ---------- Passed**
  - **Unmated ---------- 10000 Meg Ω ---------- Passed**
- **Thermal Shock**
  - **Mated ---------- 10000 Meg Ω ---------- Passed**
  - **Unmated ---------- 10000 Meg Ω ---------- Passed**
- **Humidity**
  - **Mated ---------- 10000 Meg Ω ---------- Passed**
  - **Unmated ---------- 10000 Meg Ω ---------- Passed**

Row to Row

- **Initial**
  - **Mated ---------- 10000 Meg Ω ---------- Passed**
  - **Unmated ---------- 10000 Meg Ω ---------- Passed**
- **Thermal Shock**
  - **Mated ---------- 10000 Meg Ω ---------- Passed**
  - **Unmated ---------- 10000 Meg Ω ---------- Passed**
- **Humidity**
  - **Mated ---------- 10000 Meg Ω ---------- Passed**
  - **Unmated ---------- 10000 Meg Ω ---------- Passed**

Dielectric Withstanding Voltage minimums, DWV

- **Minimums**
  - **Breakdown Voltage ---------- 1625 VAC**
  - **Test Voltage ---------- 1220 VAC**
  - **Working Voltage ---------- 405 VAC**

Pin to Pin

- **Initial DWV ---------- Passed**
- **Thermal DWV ---------- Passed**
- **Humidity DWV ---------- Passed**

Row to Row

- **Initial DWV ---------- Passed**
- **Thermal DWV ---------- Passed**
- **Humidity DWV ---------- Passed**

RESULTS Continued

LLCR Thermal Aging Group (192 LLCR test points)

- **Initial ---------- 7.84 mOhms Max**
- **Thermal**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**

LLCR Mating/Unmating Durability Group (192 LLCR test points)

- **Initial ---------- 7.93 mOhms Max**
- **Durability, 100 Cycles**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**
- **Thermal Shock**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**
- **Humidity**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**

LLCR Gas Tight Group (192 LLCR test points)

- **Initial ---------- 8.37 mOhms Max**
- **Gas-Tight**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**

RESULTS Continued

LLCR Shock & Vibration Group (192 LLCR test points)

- **Initial ---------- 7.91 mOhms Max**
- **Shock &Vibration**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**

Mechanical Shock & Random Vibration:

- **Shock**
  - **No Damage ---------- ---------- Pass**
  - **50 Nanoseconds ---------- ---------- Pass**
- **Vibration**
  - **No Damage ---------- ---------- Pass**
  - **50 Nanoseconds ---------- ---------- Pass**

LLCR Extended Life Group (192 LLCR test points)

250 cycles (SSM-125-S-DV-A/TSM-125-01-S-DH-A)

- **Initial ---------- 8.17 mOhms Max**
- **Durability, 250 Cycles**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**
- **Thermal Shock**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**
- **Humidity**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**

RESULTS Continued

500 cycles

- **Initial ---------- 8.69 mOhms Max**
- **Durability, 500 Cycles**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**
- **Thermal Shock**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**
- **Humidity**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**

1000 cycles

- **Initial ---------- 8.96 mOhms Max**
- **Durability, 1000 Cycles**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**
- **Thermal Shock**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**
- **Humidity**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**

RESULTS Continued

2500 cycles

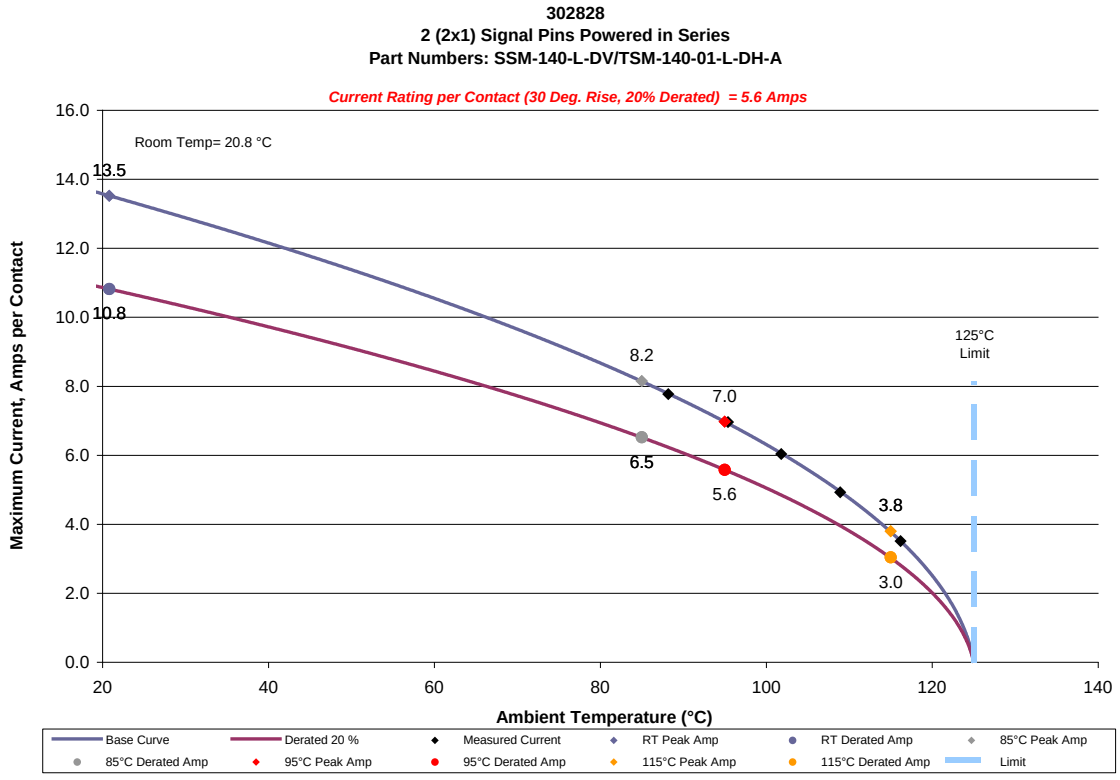
- **Initial ---------- 7.61 mOhms Max**
- **Durability, 2500 Cycles**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**
- **Thermal Shock**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**
- **Humidity**
  - **<= +5.0 mOhms ---------- 192 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 0 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**

DATA SUMMARIES

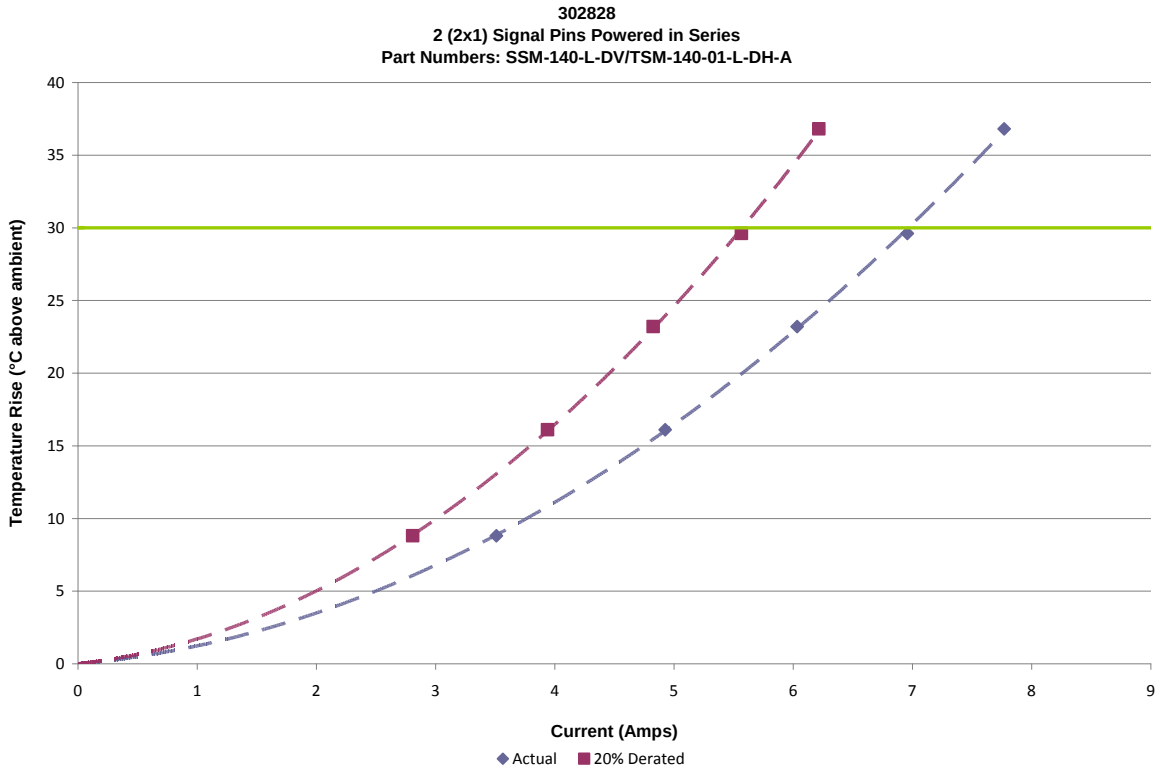
TEMPERATURE RISE (Current Carrying Capacity, CCC):

1) High quality thermocouples whose temperature slopes track one another were used for temperature monitoring.
2) The thermocouples were placed at a location to sense the maximum temperature generated during testing.
3) Temperature readings recorded are those for which three successive readings, 15 minutes apart, differ less than 1° C (computer controlled data acquisition).
4) Adjacent contacts were powered:

a. Linear configuration with 2 adjacent conductors/contacts powered

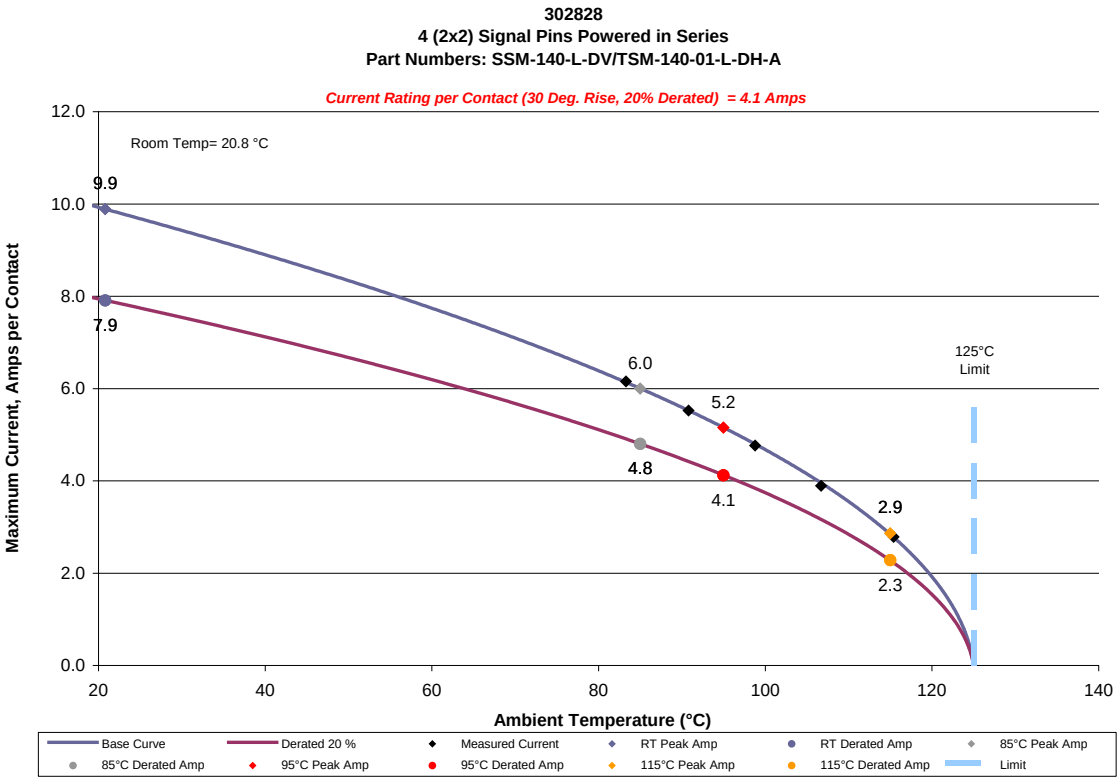


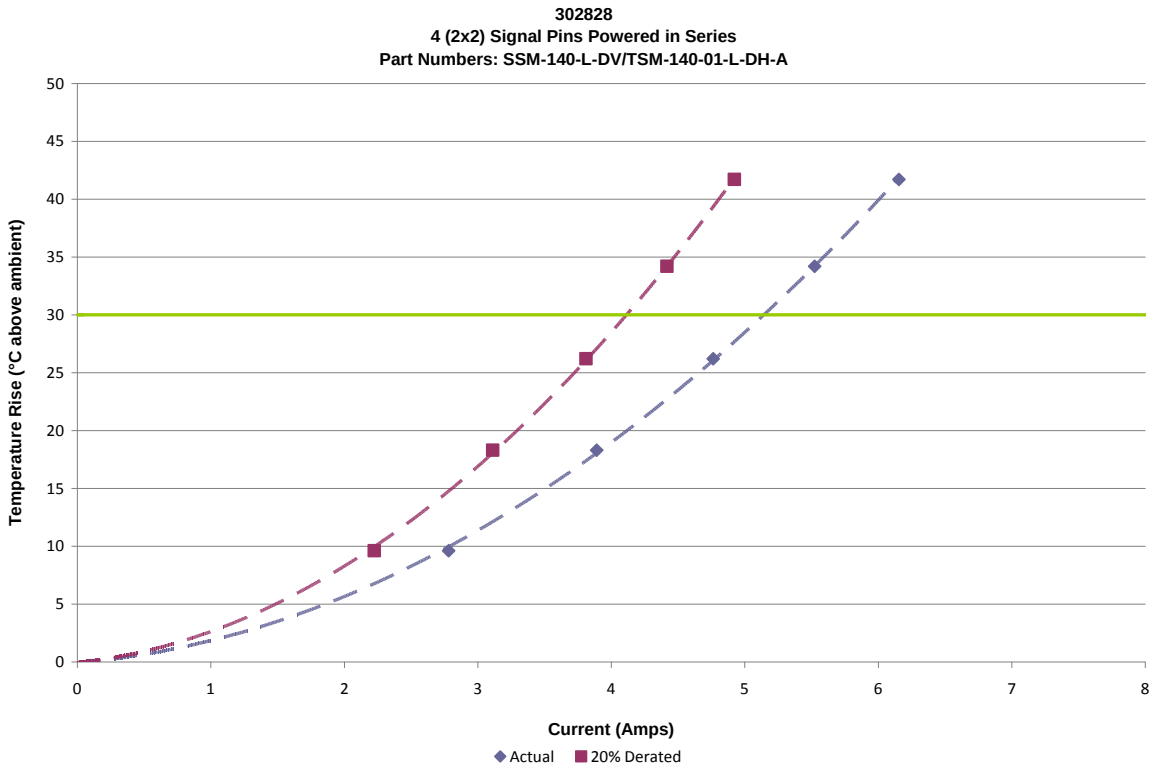
DATA SUMMARIES Continued



DATA SUMMARIES Continued

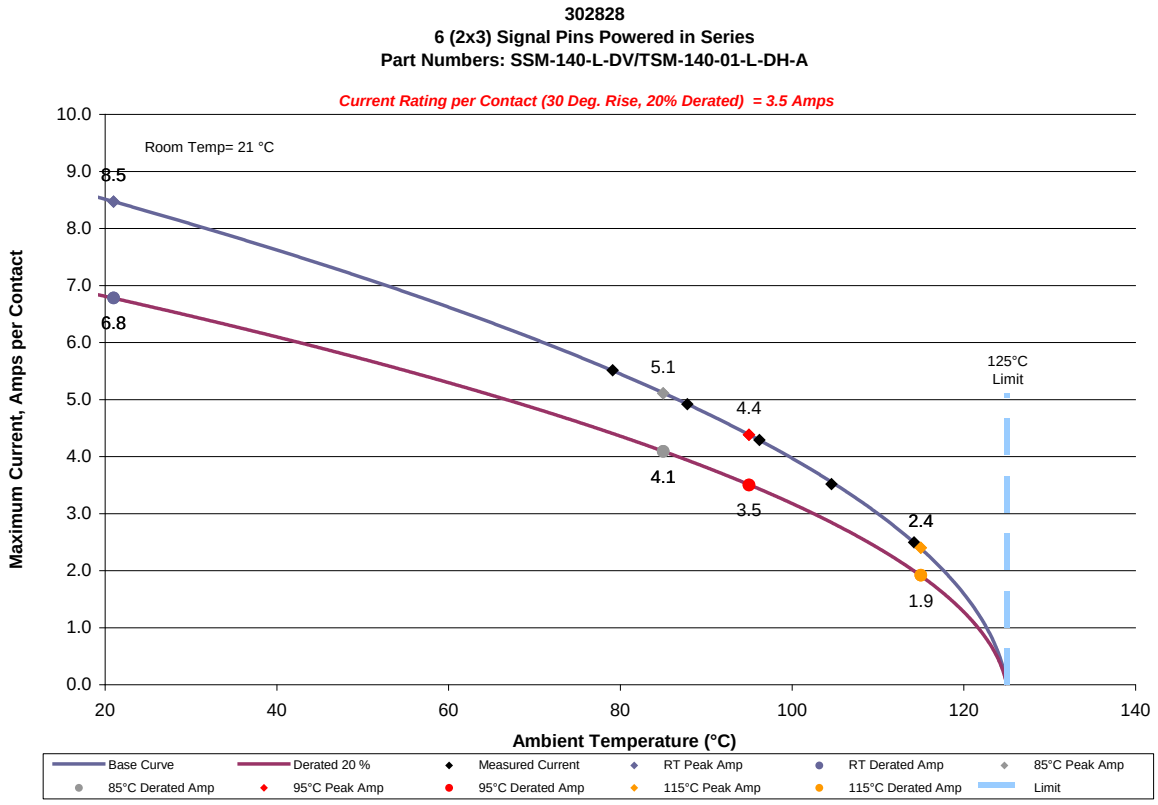
b. Linear configuration with 4 adjacent conductors/contacts powered

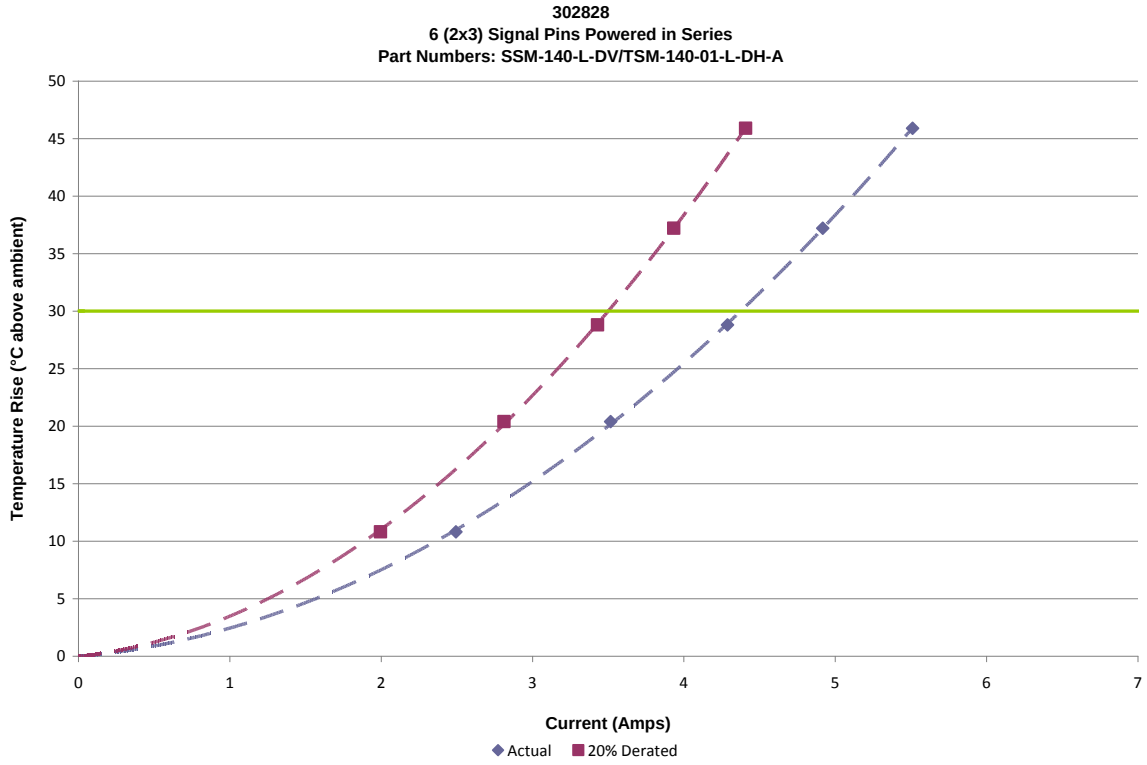




DATA SUMMARIES Continued

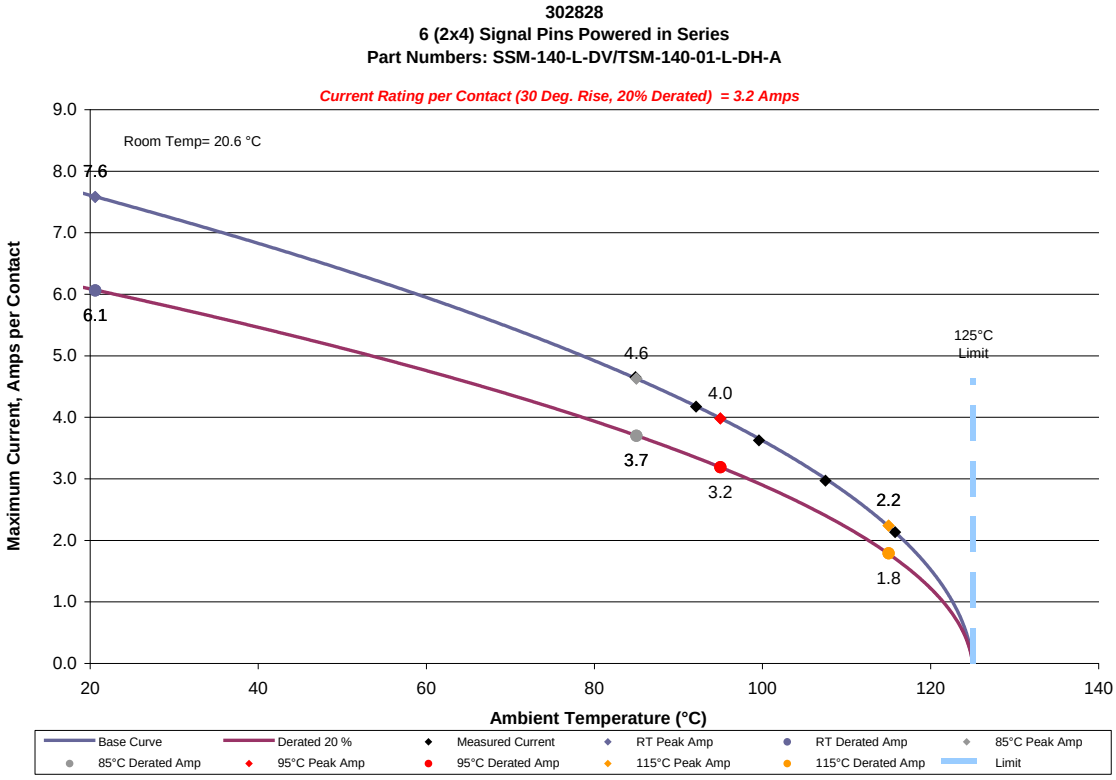
c. Linear configuration with 6 adjacent conductors/contacts powered

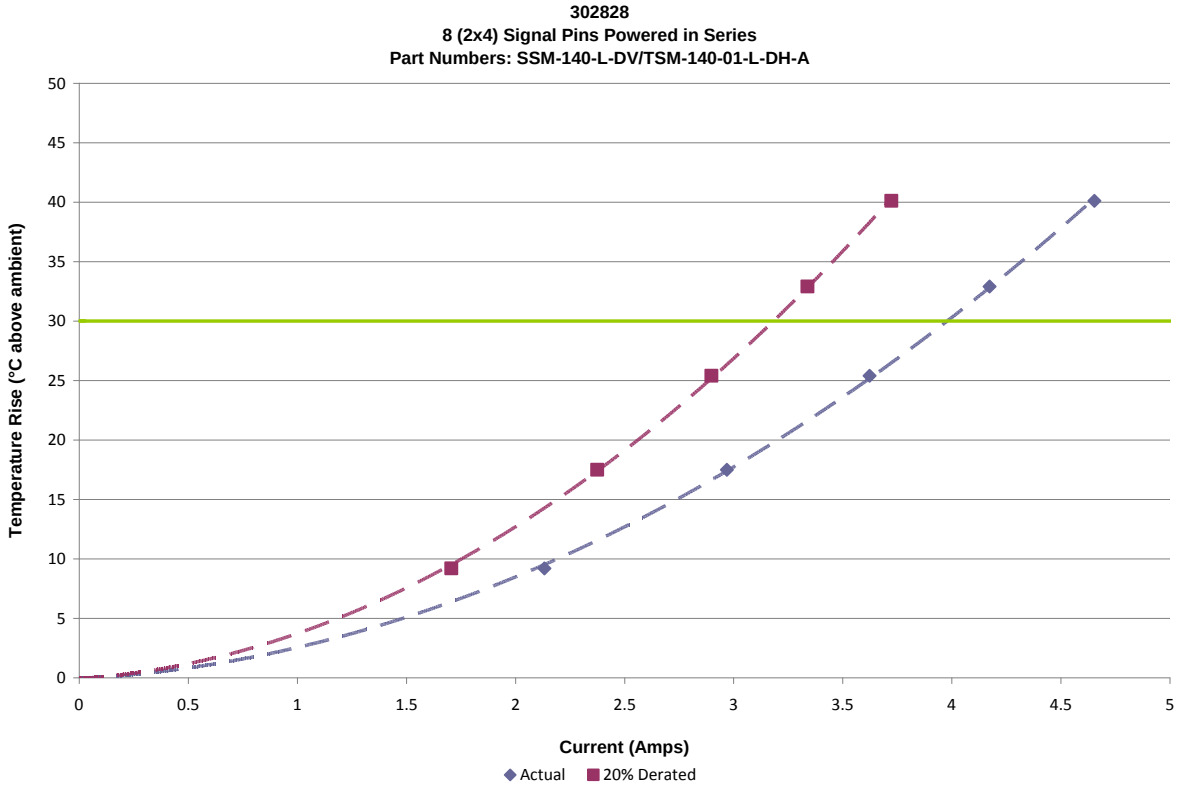




DATA SUMMARIES Continued

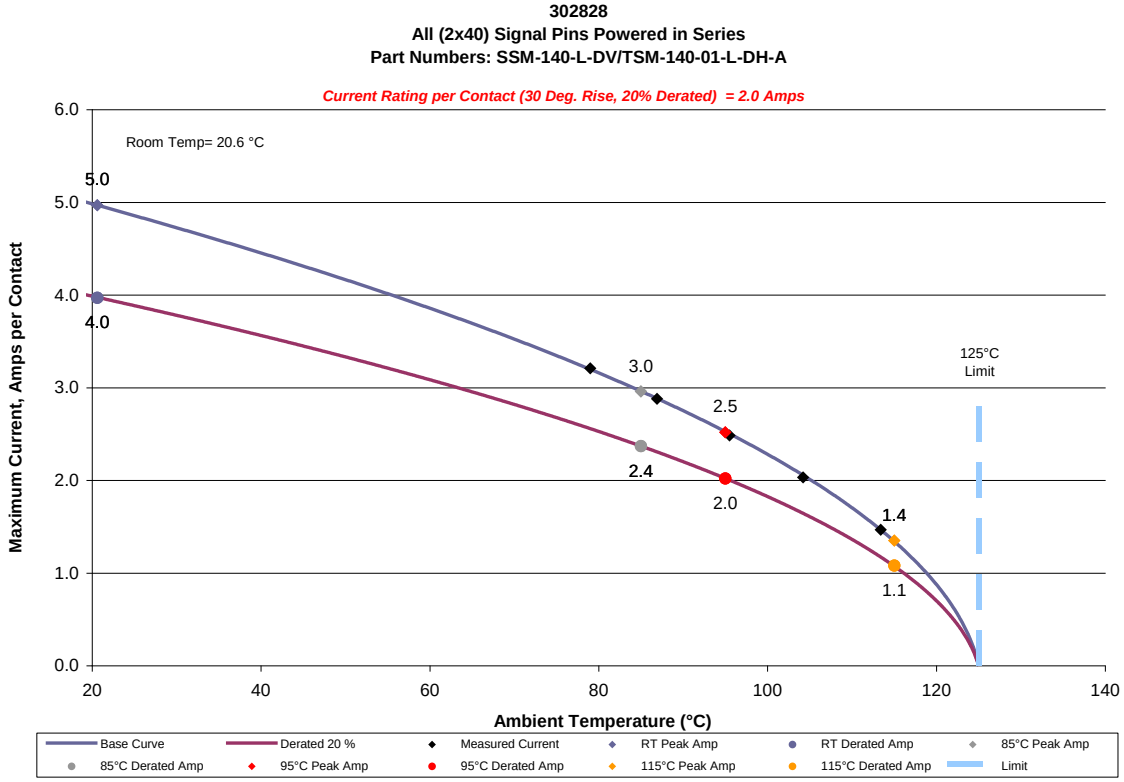
d. Linear configuration with 8 adjacent conductors/contacts powered

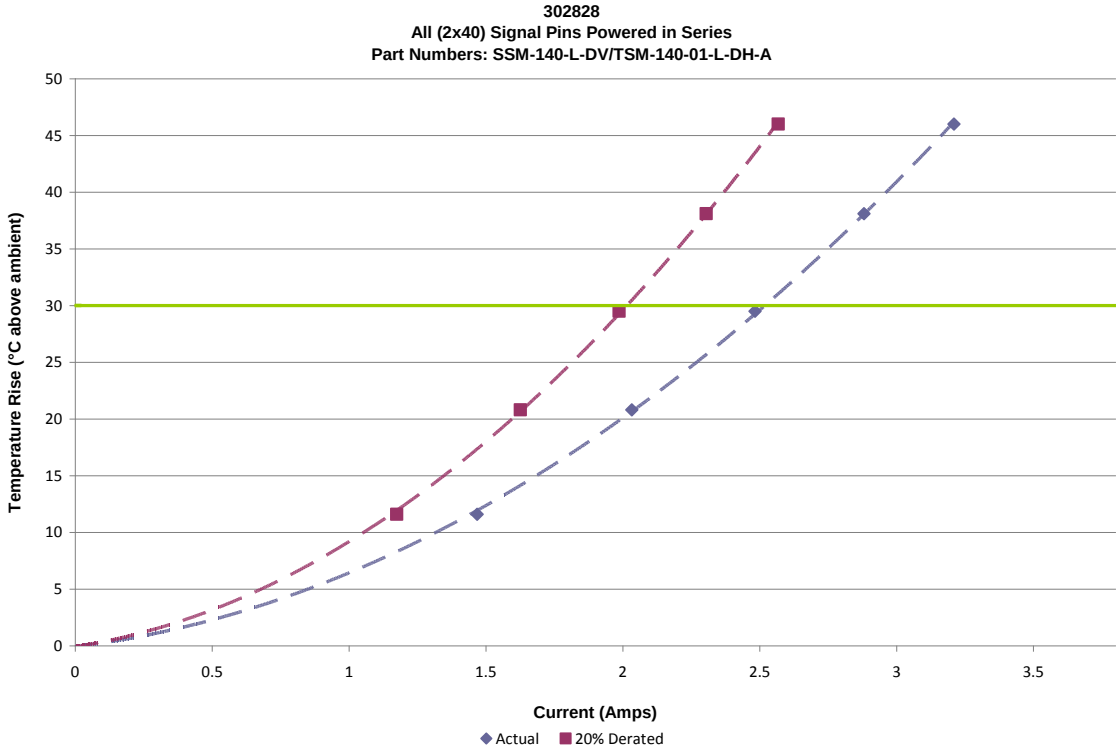




DATA SUMMARIES Continued

e. Linear configuration with all adjacent conductors/contacts powered





DATA SUMMARIES Continued

MATING-UNMATING FORCE:

Thermal Aging Group（SSM-125-L-DV-A/TSM-125-01-L-DH-A）

	Initial				After Thermals			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	31.89	7.17	25.13	5.65	28.16	6.33	24.24	5.45
Maximum	34.47	7.75	28.56	6.42	31.80	7.15	26.07	5.86
Average	33.24	**7.47**	26.24	**5.90**	30.24	**6.80**	25.08	**5.64**
St Dev	0.76	0.17	1.28	0.29	1.11	0.25	0.66	0.15
Count	8	8	8	8	8	8	8	8

Mating-Unmating Durability Gaps Group（SSM-125-L-DV-A/TSM-125-01-L-DH-A）

	Initial				After 25 Cycles			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	30.07	6.76	25.84	5.81	33.67	7.57	27.13	6.10
Maximum	36.61	8.23	31.80	7.15	44.57	10.02	36.16	8.13
Average	32.28	**7.26**	28.48	**6.40**	37.47	**8.42**	31.71	**7.13**
St Dev	2.13	0.48	1.83	0.41	3.44	0.77	2.61	0.59
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	39.05	8.78	32.16	7.23	41.86	9.41	36.12	8.12
Maximum	51.95	11.68	38.96	8.76	54.40	12.23	41.01	9.22
Average	42.23	**9.50**	36.17	**8.13**	45.71	**10.28**	39.14	**8.80**
St Dev	4.33	0.97	2.11	0.48	4.40	0.99	1.70	0.38
Count	8	8	8	8	8	8	8	8
	After 100 Cycles				After Humidity			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	45.24	10.17	40.61	9.13	31.54	7.09	24.55	5.52
Maximum	56.31	12.66	43.90	9.87	44.30	9.96	33.23	7.47
Average	49.25	**11.07**	42.14	**9.47**	36.38	**8.18**	28.67	**6.45**
St Dev	4.31	0.97	1.24	0.28	4.96	1.11	3.35	0.75
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued

Mating-Unmating Basic (SSM-140-L-DV-A/TSM-140-01-L-DH-A**)**

	Initial				After 25 Cycles			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	56.49	12.70	45.50	10.23	60.76	13.66	51.86	11.66
Maximum	62.41	14.03	49.37	11.10	70.06	15.75	56.58	12.72
Average	58.44	**13.14**	48.01	**10.79**	64.95	**14.60**	53.93	**12.13**
St Dev	2.01	0.45	1.47	0.33	2.67	0.60	1.77	0.40
Count	8	8	8	8	8	8	8	8

	After 50 Cycles				After 75 Cycles			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	62.85	14.13	56.31	12.66	72.19	16.23	58.40	13.13
Maximum	76.19	17.13	60.05	13.50	82.02	18.44	72.19	16.23
Average	69.78	**15.69**	58.27	**13.10**	75.68	**17.01**	63.46	**14.27**
St Dev	3.74	0.84	1.56	0.35	3.12	0.70	4.42	0.99
Count	8	8	8	8	8	8	8	8

	After 100 Cycles			
	Mating		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	75.53	16.98	61.43	13.81
Maximum	83.44	18.76	77.17	17.35
Average	79.55	**17.89**	66.84	**15.03**
St Dev	2.59	0.58	5.06	1.14
Count	8	8	8	8

DATA SUMMARIES Continued

Mating-Unmating Basic (SSM-110-L-DV-A/TSM-110-01-L-DH-A**)**

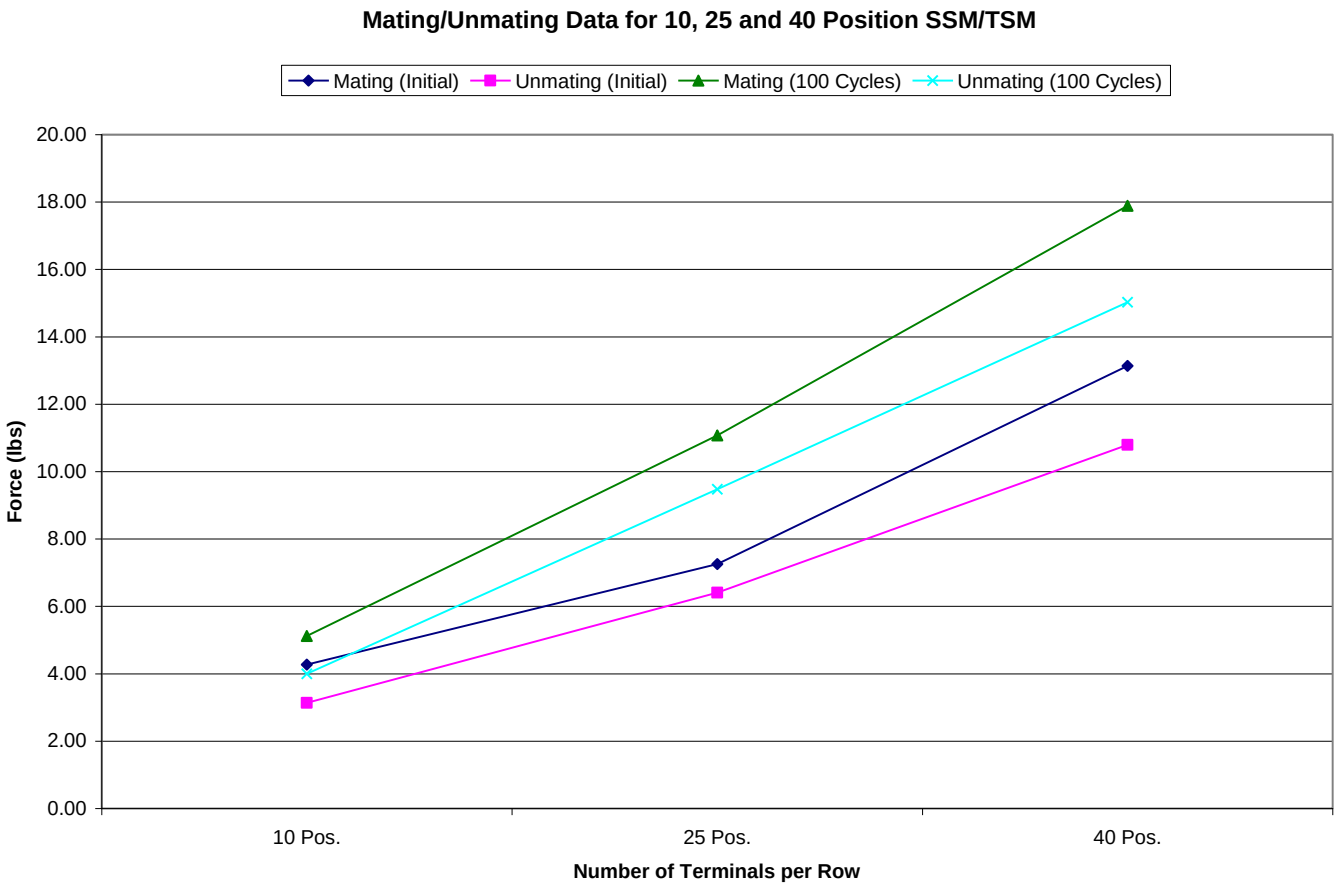
	Initial				25 Cycles			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	16.86	3.79	13.43	3.02	17.79	4.00	13.79	3.10
Maximum	20.33	4.57	14.77	3.32	21.53	4.84	16.32	3.67
Average	18.99	**4.27**	13.94	**3.13**	20.04	**4.51**	15.32	**3.44**
St Dev	1.11	0.25	0.45	0.10	1.19	0.27	1.05	0.24
Count	8	8	8	8	8	8	8	8

	50 Cycles				75 Cycles			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	18.33	4.12	14.37	3.23	18.82	4.23	15.17	3.41
Maximum	22.95	5.16	18.24	4.10	23.57	5.30	18.73	4.21
Average	20.92	**4.70**	16.35	**3.68**	22.02	**4.95**	17.11	**3.85**
St Dev	1.41	0.32	1.38	0.31	1.44	0.32	1.28	0.29
Count	8	8	8	8	8	8	8	8

	100 Cycles			
	Mating		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	20.24	4.55	16.10	3.62
Maximum	24.24	5.45	18.90	4.25
Average	22.76	**5.12**	17.79	**4.00**
St Dev	1.17	0.26	1.08	0.24
Count	8	8	8	8

DATA SUMMARIES Continued

Mating\Unmating Force Comparison



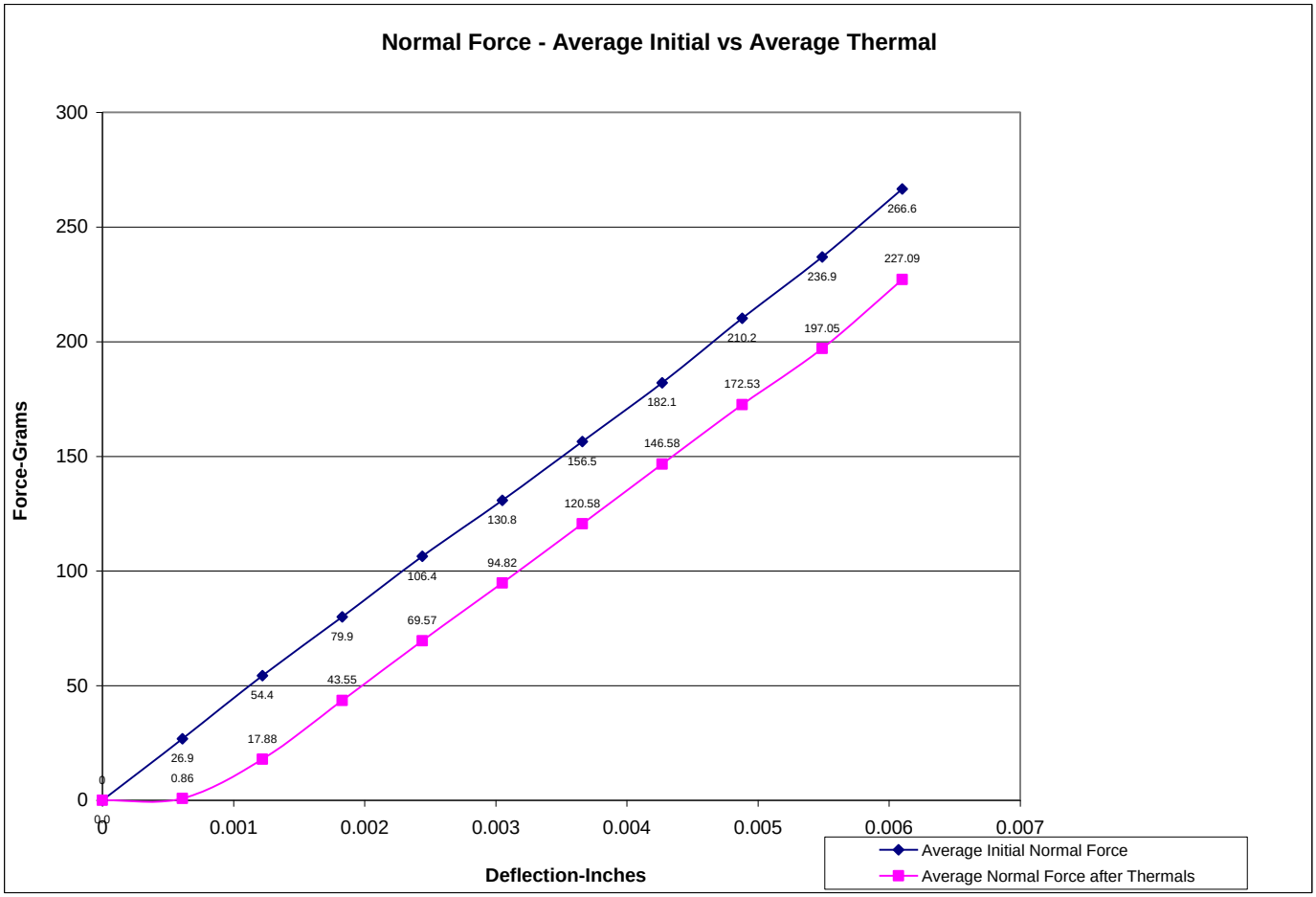
DATA SUMMARIES Continued

NORMAL FORCE (FOR CONTACTS TESTED OUT THE HOUSING):

1) Calibrated force gauges are used along with computer controlled positioning equipment.
2) For Normal force 8-10 measurements are taken and the averages reported.

Initial	Deflections in inches Forces in Grams										
	0.0006	**0.0012**	**0.0018**	**0.0024**	**0.0031**	**0.0037**	**0.0043**	**0.0049**	**0.0055**	**0.0061**	***SET***
Averages	26.85	54.39	79.94	106.38	130.83	156.48	182.09	210.18	236.89	266.57	0.0005
Min	20.00	45.50	70.00	95.50	117.70	144.80	169.10	192.10	215.10	243.50	0.0000
Max	32.30	61.20	95.60	120.10	150.30	175.40	200.70	232.80	258.40	289.70	0.0008
St. Dev	4.299	4.788	7.110	7.433	9.280	8.543	9.933	12.499	14.388	15.463	0.0002
Count	12	12	12	12	12	12	12	12	12	12	12

After Thermals	Deflections in inches Forces in Grams										
	0.0006	**0.0012**	**0.0018**	**0.0024**	**0.0031**	**0.0037**	**0.0043**	**0.0049**	**0.0055**	**0.0061**	***SET***
Averages	0.86	17.88	43.55	69.57	94.82	120.58	146.58	172.53	197.05	227.09	0.0007
Min	-0.40	8.50	30.00	50.30	70.60	91.30	111.70	133.60	156.20	187.20	0.0003
Max	8.40	33.10	57.20	80.90	109.40	138.00	166.80	194.20	223.10	254.30	0.0010
St. Dev	2.429	8.585	10.337	11.078	13.787	16.088	17.804	20.632	23.696	24.926	0.0002
Count	12	12	12	12	12	12	12	12	12	12	12



DATA SUMMARIES Continued

INSULATION RESISTANCE (IR):

	Pin to Pin		
	Mated	Unmated	Unmated
Minimum	**SSM/TSM**	**SSM**	**TSM**
Initial	10000	10000	10000
Thermal	10000	10000	10000
Humidity	10000	10000	10000

	Row to Row		
	Mated	Unmated	Unmated
Minimum	**SSM/TSM**	**SSM**	**TSM**
Initial	10000	10000	10000
Thermal	10000	10000	10000
Humidity	10000	10000	10000

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

Voltage Rating Summary	
Minimum	**SSM/TSM**
Break Down Voltage	1625
Test Voltage	1220
Working Voltage	405

Pin to Pin	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

Row to Row	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

DATA SUMMARIES Continued

LLCR Thermal Aging Group

1) A total of 192 points were measured.
2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.*
3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
   a. <= +5.0 mOhms:----------Stable
   b. +5.1 to +10.0 mOhms:----------Minor
   c. +10.1 to +15.0 mOhms: ----------Acceptable
   d. +15.1 to +50.0 mOhms: ----------Marginal
   e. +50.1 to +2000 mOhms ----------Unstable
   f. >+2000 mOhms:----------Open Failure

LLCR Measurement Summaries by Pin Type				
Date	3/26/2014	4/8/2014		
Room Temp (Deg C)	21	21		
Rel Humidity (%)	56	54		
Technician	Peter Chen	Peter Chen		
mOhm values	**Actual Initial**	**Delta Thermal**	**Delta**	**Delta**
	Pin Type 1: Signal			
Average	6.10	0.41		
St. Dev.	0.84	0.48		
Min	4.54	0.00		
Max	7.84	2.74		
Summary Count	192	192		
Total Count	192	192		

LLCR Delta Count by Category						
	Stable	**Minor**	**Acceptable**	**Marginal**	**Unstable**	**Open**
mOhms	**<=5**	**>5 & <=10**	**>10 & <=15**	**>15 & <=50**	**>50 & <=1000**	**>1000**
Thermal	**192**	**0**	**0**	**0**	**0**	**0**

DATA SUMMARIES Continued

LLCR Mating/Unmating Durability Group

1). A total of 192 points were measured.
2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.*
3). A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
4). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
   a. <= +5.0 mOhms:----------Stable
   b. +5.1 to +10.0 mOhms: ----------Minor
   c. +10.1 to +15.0 mOhms: ----------Acceptable
   d. +15.1 to +50.0 mOhms: ----------Marginal
   e. +50.1 to +2000 mOhms ----------Unstable
   f. > +2000 mOhms:----------Open Failure

LLCR Measurement Summaries by Pin Type				
Date	3/20/2014	3/26/2014	3/31/2014	4/11/2014
Room Temp (Deg C)	22	21	21	21
Rel Humidity (%)	56	56	56	56
Technician	Peter Chen	Peter Chen	Peter Chen	Peter Chen
mOhm values	**Actual Initial**	**Delta 100 Cycles**	**Delta Therm Shck**	**Delta Humidity**
	Pin Type 1: Signal			
Average	6.26	0.41	0.38	0.52
St. Dev.	0.83	0.34	0.36	0.48
Min	4.67	0.00	0.00	0.00
Max	7.93	1.74	1.74	3.68
Summary Count	192	192	192	192
Total Count	192	192	192	192

LLCR Delta Count by Category						
	Stable	**Minor**	**Acceptable**	**Marginal**	**Unstable**	**Open**
mOhms	**<=5**	**>5 & <=10**	**>10 & <=15**	**>15 & <=50**	**>50 & <=1000**	**>1000**
100 Cycles	**192**	**0**	**0**	**0**	**0**	**0**
Therm Shck	**192**	**0**	**0**	**0**	**0**	**0**
Humidity	**192**	**0**	**0**	**0**	**0**	**0**

DATA SUMMARIES Continued

LLCR Gas Tight Group

1) A total of 192 points were measured.
2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.*
3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
   a. <= +5.0 mOhms: ---------- Stable
   b. +5.1 to +10.0 mOhms: ---------- Minor
   c. +10.1 to +15.0 mOhms: ---------- Acceptable
   d. +15.1 to +50.0 mOhms: ---------- Marginal
   e. +50.1 to +2000 mOhms: ---------- Unstable
   f. >+2000 mOhms: ---------- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	4/1/2014	4/15/2014		
Room Temp (Deg C)	21	21		
Rel Humidity (%)	56	56		
Technician	Peter Chen	Peter Chen		
mOhm values	**Actual Initial**	**Delta Acid Vapor**	**Delta**	**Delta**
	Pin Type 1: Signal			
Average	6.20	0.38		
St. Dev.	0.84	0.39		
Min	4.71	0.00		
Max	8.37	1.97		
Summary Count	192	192		
Total Count	192	192		

LLCR Delta Count by Category						
	Stable	**Minor**	**Acceptable**	**Marginal**	**Unstable**	**Open**
mOhms	**<=5**	**>5 & <=10**	**>10 & <=15**	**>15 & <=50**	**>50 & <=1000**	**>1000**
Acid Vapor	**192**	**0**	**0**	**0**	**0**	**0**

DATA SUMMARIES Continued

LLCR Shock & Vibration Group

1) A total of 192 points were measured.
2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.*
3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
   a. <= +5.0 mOhms: ---------- Stable
   b. +5.1 to +10.0 mOhms: ---------- Minor
   c. +10.1 to +15.0 mOhms: ---------- Acceptable
   d. +15.1 to +50.0 mOhms: ---------- Marginal
   e. +50.1 to +2000 mOhms ---------- Unstable
   f. >+2000 mOhms: ---------- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	4/9/2014	5/9/2014		
Room Temp (Deg C)	23	23		
Rel Humidity (%)	38	37		
Technician	Aaron McKim	Aaron McKim		
mOhm values	**Actual Initial**	**Delta Shock-Vib**	**Delta**	**Delta**
	Pin Type 1: Signal			
Average	6.17	0.46		
St. Dev.	0.82	0.33		
Min	4.52	0.00		
Max	7.91	1.66		
Summary Count	192	192		
Total Count	192	192		

LLCR Delta Count by Category						
	Stable	**Minor**	**Acceptable**	**Marginal**	**Unstable**	**Open**
mOhms	**<=5**	**>5 & <=10**	**>10 & <=15**	**>15 & <=50**	**>50 & <=1000**	**>1000**
Shock-Vib	**192**	**0**	**0**	**0**	**0**	**0**

Nanosecond Event Detection:

Shock and Vibration Event Detection Summary	
Contacts tested	60
Test Condition	C, 100g's, 6ms, Half-Sine
Shock Events	0
Test Condition	V-B, 7.56 rms g
Vibration Events	0
Total Events	0

DATA SUMMARIES Continued

LLCR Extended Life Group (SSM-125-S-DV-A/TSM-125-01-S-DH-A)

1). A total of 192 points were measured.
2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.*
3). A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
4). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
   a. <= +5.0 mOhms:----------Stable
   b. +5.1 to +10.0 mOhms: ----------Minor
   c. +10.1 to +15.0 mOhms: ----------Acceptable
   d. +15.1 to +50.0 mOhms: ----------Marginal
   e. +50.1 to +2000 mOhms ----------Unstable
   f. > +2000 mOhms:----------Open Failure

250 cycles

LLCR Measurement Summaries by Pin Type				
Date	4/8/2014	4/10/2014	4/16/2014	5/4/2014
Room Temp (Deg C)	21	22	21	21
Rel Humidity (%)	23	56	56	54
Technician	Peter Chen	Peter Chen	Peter Chen	
mOhm values	**Actual Initial**	**Delta 250 Cycles**	**Delta Therm Shck**	**Delta Humidity**
	Pin Type 1: Signal			
Average	5.87	0.53	0.45	0.99
St. Dev.	0.84	0.43	0.39	0.75
Min	4.28	0.01	0.00	0.01
Max	8.17	3.11	3.13	2.88
Summary Count	192	192	192	192
Total Count	192	192	192	192

LLCR Delta Count by Category						
	Stable	**Minor**	**Acceptable**	**Marginal**	**Unstable**	**Open**
mOhms	**<=5**	**>5 & <=10**	**>10 & <=15**	**>15 & <=50**	**>50 & <=1000**	**>1000**
250 Cycles	**192**	**0**	**0**	**0**	**0**	**0**
Therm Shck	**192**	**0**	**0**	**0**	**0**	**0**
Humidity	**192**	**0**	**0**	**0**	**0**	**0**

DATA SUMMARIES Continued

500 cycles

	LLCR Measurement Summaries by Pin Type			
Date	4/8/2014	4/10/2014	4/16/2014	5/5/2014
Room Temp (Deg C)	21	21	21	21
Rel Humidity (%)	56	56	56	56
Technician	Peter Chen	Peter Chen	Peter Chen	Peter Chen
mOhm values	**Actual Initial**	**Delta 500 Cycles**	**Delta Therm Shck**	**Delta Humidity**
	Pin Type 1: Signal			
Average	6.08	0.64	0.61	0.66
St. Dev.	0.91	0.63	0.63	0.67
Min	4.48	0.01	0.00	0.01
Max	8.69	3.90	3.85	4.00
Summary Count	192	192	192	192
Total Count	192	192	192	192

LLCR Delta Count by Category						
	Stable	**Minor**	**Acceptable**	**Marginal**	**Unstable**	**Open**
mOhms	**<=5**	**>5 & <=10**	**>10 & <=15**	**>15 & <=50**	**>50 & <=1000**	**>1000**
500 Cycles	**192**	**0**	**0**	**0**	**0**	**0**
Therm Shck	**192**	**0**	**0**	**0**	**0**	**0**
Humidity	**192**	**0**	**0**	**0**	**0**	**0**

1000 cycles

	LLCR Measurement Summaries by Pin Type			
Date	4/9/2014	4/18/2014	4/28/2014	5/13/2014
Room Temp (Deg C)	22	21	21	21
Rel Humidity (%)	56	56	56	54
Technician	Peter Chen	Peter Chen	Peter Chen	Peter Chen
mOhm values	**Actual Initial**	**Delta 1000 Cycles**	**Delta Therm Shck**	**Delta Humidity**
	Pin Type 1: Signal			
Average	6.02	0.58	0.53	0.58
St. Dev.	0.90	0.55	0.54	0.52
Min	4.25	0.00	0.00	0.00
Max	8.96	3.21	2.98	2.99
Summary Count	192	192	192	192
Total Count	192	192	192	192

LLCR Delta Count by Category						
	Stable	**Minor**	**Acceptable**	**Marginal**	**Unstable**	**Open**
mOhms	**<=5**	**>5 & <=10**	**>10 & <=15**	**>15 & <=50**	**>50 & <=1000**	**>1000**
1000 Cycles	**192**	**0**	**0**	**0**	**0**	**0**
Therm Shck	**192**	**0**	**0**	**0**	**0**	**0**
Humidity	**192**	**0**	**0**	**0**	**0**	**0**

DATA SUMMARIES Continued

2500 cycles

	LLCR Measurement Summaries by Pin Type			
Date	4/9/2014	4/18/2014	4/28/2014	5/13/2014
Room Temp (Deg C)	22	21	21	21
Rel Humidity (%)	56	56	56	54
Technician	Peter Chen	Peter Chen	Peter Chen	Peter Chen
mOhm values	**Actual Initial**	**Delta 2500 Cycles**	**Delta Therm Shck**	**Delta Humidity**
	Pin Type 1: Signal			
Average	5.85	0.49	0.47	0.57
St. Dev.	0.81	0.43	0.45	0.48
Min	4.21	0.01	0.00	0.01
Max	7.61	2.28	2.33	2.45
Summary Count	192	192	192	192
Total Count	192	192	192	192

LLCR Delta Count by Category						
	Stable	**Minor**	**Acceptable**	**Marginal**	**Unstable**	**Open**
mOhms	**<=5**	**>5 & <=10**	**>10 & <=15**	**>15 & <=50**	**>50 & <=1000**	**>1000**
2500 Cycles	**192**	**0**	**0**	**0**	**0**	**0**
Therm Shck	**192**	**0**	**0**	**0**	**0**	**0**
Humidity	**192**	**0**	**0**	**0**	**0**	**0**

EQUIPMENT AND CALIBRATION SCHEDULES

Equipment #: HZ-TCT-01
Description: Normal force analyzer
Manufacturer: Mecmesin Multitester
Model: Mecmesin Multitester 2.5-i
Serial #: 08-1049-04
Accuracy: Last Cal: 4/26/2014, Next Cal: 4/25/2015

Equipment #: HZ-OV-01
Description: Oven
Manufacturer: Huida
Model: CS101-1E
Serial #: CS101-1E-B
Accuracy: Last Cal: 12/13/2014, Next Cal: 12/12/2015

Equipment #: HZ-THC-01
Description: Humidity transmitter
Manufacturer: Thermtron
Model: SM-8-8200
Serial #: 38846
Accuracy: Last Cal: 2/28/2014, Next Cal: 2/27/2015

Equipment #: HZ-TSC-01
Description: Vertical Thermal Shock Chamber
Manufacturer: Cincinnatti Sub Zero
Model: VTS-3-6-6-SC/AC
Serial #: 10-VT14994
Accuracy: See Manual
… Last Cal: 06/28/2014, Next Cal: 06/27/2015

Equipment #: HZ-HPM-01
Description: NA9636H
Manufacturer: Ainuo
Model: 6031A
Serial #: 089601091
Accuracy: Last Cal: 3/7/2014, Next Cal: 3/6/2015

Equipment #: HZ-MO-05
Description: Micro-ohmmeter
Manufacturer: Keithley
Model: 3706
Serial #: 1285188
Accuracy: Last Cal: 11/15/2014, Next Cal: 11/14/2015

EQUIPMENT AND CALIBRATION SCHEDULES Continued

Equipment #: MO-04
Description: Multimeter /Data Acquisition System
Manufacturer: Keithley
Model: 2700
Serial #: 0798688
Accuracy: See Manual
… Last Cal: 04/30/2014, Next Cal: 04/30/2015

Equipment #: HZ-MO-01
Description: Micro-ohmmeter
Manufacturer: Keithley
Model: 2700
Serial #: 1199807
Accuracy: Last Cal: 04/28/2014, Next Cal: 04/28/2015

Equipment #: HZ-PS-01
Description: Power Supply
Manufacturer: Agilent
Model: 6031A
Serial #: MY41000982
Accuracy: Last Cal: 04/28/2014, Next Cal: 04/28/2015

Equipment #: SVC-01
Description: Shock & Vibration Table
Manufacturer: Data Physics
Model: LE-DSA-10-20K
Serial #: 10037
Accuracy: See Manual
… Last Cal: 11/31/2014, Next Cal: 11/31/2015

Equipment #: ACLM-01
Description: Accelerometer
Manufacturer: PCB Piezotronics
Model: 352C03
Serial #: 115819
Accuracy: See Manual
… Last Cal: 07/09/2014, Next Cal: 07/09/2015

Equipment #: ED-03
Description: Event Detector
Manufacturer: Analysis Tech
Model: 32EHD
Serial #: 1100604
Accuracy: See Manual
… Last Cal: 06/04/2014, Next Cal: 06/04/2015